

Search Notes

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Examiner

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Applicant(s)/Patent under
Reexamination

ITOH ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
ABOVE	Updated	2/19/2007	HN
709	220, 221	2/20/2007	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (see search history printout report)	2/19/2007	HN
Limited classified search: 709/220, 221 (see search history printout report)	2/20/2007	HN